Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10512065	NAKAMURA, HIROTO
Examiner	Art Unit
TRUNG Q NGUYEN	2829

SEARCHED								
Class	Subclass	Date	Examiner					
324	73.1, 158.1, 754-758, 760-765.	07/23/08	QT					
209	571-572	07/23/08	QT					
439	482, 824	07/23/08	QT					
29	840, 832, 843	07/23/08	QT					

SEARCH NOTES				
Search Notes	Date	Examiner		
Keywords: semiconductor\$1 and tray\$1 and mov\$3 and test\$3 and strip\$1 and socket\$1	07/23/08	QT		

Class	Subclass	3	Date	Examiner
PG-PUB Search	See attached search		07/23/08	QT

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